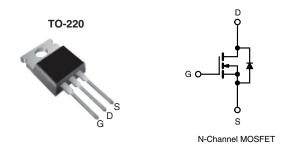




## **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	60			
$R_{DS(on)}$ ( $\Omega$ )	V <sub>GS</sub> = 10 V	0.20		
Q <sub>g</sub> (Max.) (nC)	11			
Q <sub>gs</sub> (nC)	3.1			
Q <sub>gd</sub> (nC)	5.8			
Configuration	Single			



#### **FEATURES**

- · Dynamic dv/dt Rating
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available



### **DESCRIPTION**

Third Generation Power MOSFETs from Vishay provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION		
Package	TO-220	
Lood (Ph) from	IRFZ10PbF	
Lead (Pb)-free	SiHFZ10-E3	
SnPb	IRFZ10	
	SiHFZ10	

PARAMETER			SYMBOL	LIMIT	UNIT	
Gate-Source Voltage			$V_{GS}$	± 20	V	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	10	А	
		T <sub>C</sub> = 100 °C		7.2		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	40	1	
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	47	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		$P_{D}$	43	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>		
	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \,^{\circ}\text{C}$ ,  $L = 1.8 \,\text{mH}$ ,  $R_G = 25 \,\Omega$ ,  $I_{AS} = 7.2 \,\text{A}$  (see fig. 12).
- c.  $I_{SD} \leq$  10 A,  $dI/dt \leq$  90 A/µs,  $V_{DD} \leq V_{DS}, \, T_J \leq$  175 °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

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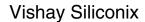


THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.5		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0	60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.063	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V$	$I_{GS}$ , $I_{D} = 250  \mu A$	2.0	-	4.0	٧
Gate-Source Leakage	$I_{GSS}$	V <sub>GS</sub> = ± 20		1	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 0$	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V		-	25	μΑ
Zero date voltage Brain ounem		V <sub>DS</sub> = 48 V, V	<sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 6.0 A <sup>b</sup>	-	-	0.20	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 25 \text{ V}, I_D = 6.0 \text{ A}^b$		2.4	-	-	S
Dynamic		_					
Input Capacitance	$C_{iss}$	V <sub>GS</sub> = 0 V		-	300	-	pF
Output Capacitance	$C_{oss}$	V	V <sub>DS</sub> = 25 V		160	-	
Reverse Transfer Capacitance	$C_{rss}$	f = 1.0 MHz, see fig. 5		-	29	-	
Total Gate Charge	$Q_g$	V <sub>GS</sub> = 10 V	$I_D = 10 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	11	nC
Gate-Source Charge	Q <sub>gs</sub>			-	-	3.1	
Gate-Drain Charge	$Q_{gd}$			-	-	5.8	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 30 V, $I_D$ = 10 A $R_G$ = 24 $\Omega$ , $R_D$ = 2.7 $\Omega$ , see fig. 10 <sup>b</sup>		-	10	-	- ns
Rise Time	t <sub>r</sub>			-	50	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	13	-	
Fall Time	t <sub>f</sub>			1	19	-	
Internal Drain Inductance	$L_{D}$	Between lead, 6 mm (0.25") from package and center of die contact		1	4.5	-	nH
Internal Source Inductance	L <sub>S</sub>			1	7.5	-	III
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	40	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 10 A, di/dt = 100 A/μs <sup>b</sup>		-	70	140	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.20	0.40	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn	on is dominated by $L_S$ and $L_D$ )				

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$





### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

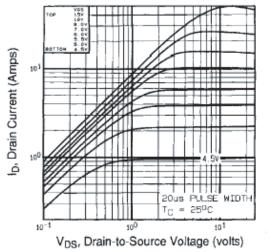


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

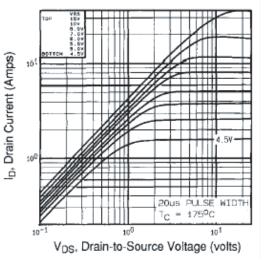


Fig. 2 - Typical Output Characteristics,  $T_C = 175$  °C

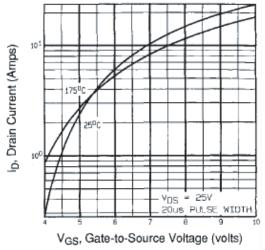


Fig. 3 - Typical Transfer Characteristics

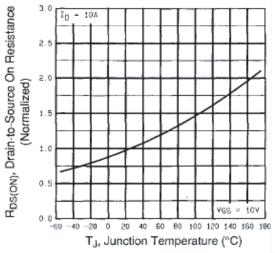


Fig. 4 - Normalized On-Resistance vs. Temperature

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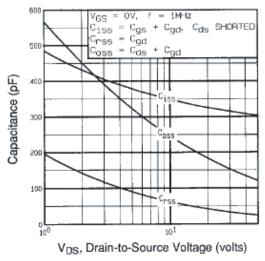


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

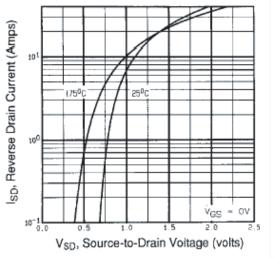


Fig. 7 - Typical Source-Drain Diode Forward Voltage

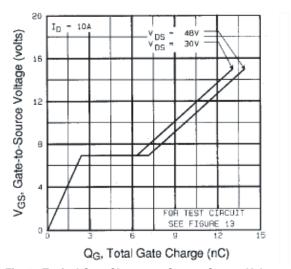


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

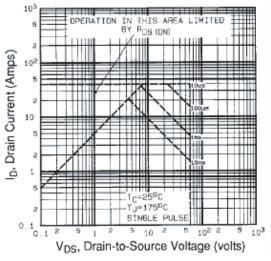
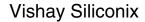


Fig. 8 - Maximum Safe Operating Area





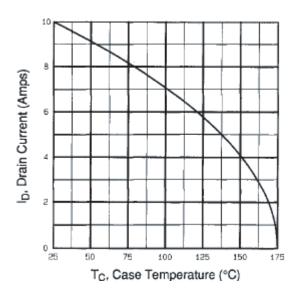


Fig. 9 - Maximum Drain Current vs. Case Temperature

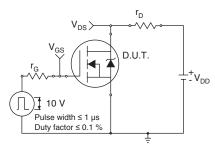


Fig. 10a - Switching Time Test Circuit

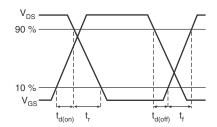


Fig. 10b - Switching Time Waveforms

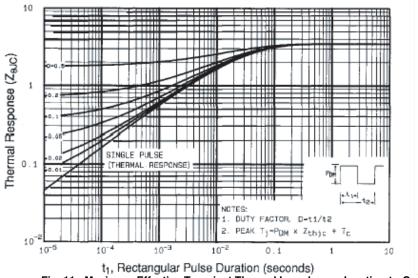


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

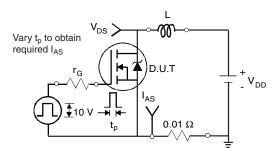


Fig. 12a - Unclamped Inductive Test Circuit

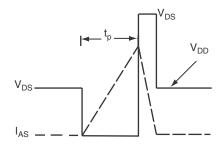


Fig. 12b - Unclamped Inductive Waveforms

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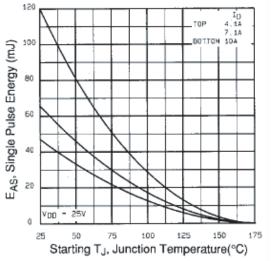


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

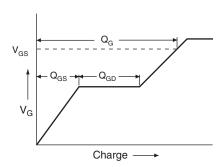


Fig. 13a - Basic Gate Charge Waveform

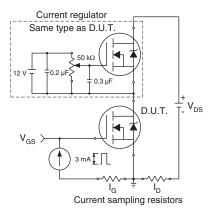
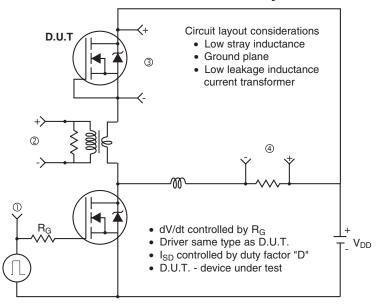
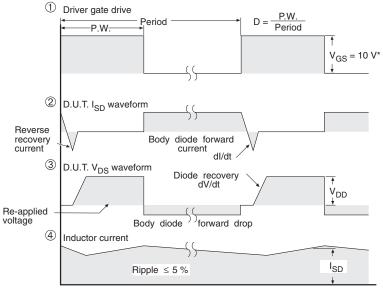


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit





\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

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